## Application/Control No. O9/517,018 Applicant(s)/Patent Under Reexamination OKAMURA; HIDEAKI Examiner LeChi Truong Applicant(s)/Patent Under Reexamination OKAMURA; HIDEAKI Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,430,607 B1	10-1998	Kavner, Gene D.	709/217
	В	US-5,560,012	09-1996	Ryu et al.	717/104
	С	US-5,386,568	01-1995	Wold et al.	717/162
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q			1.00		
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	v							
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.